

<b>Notice of References Cited</b>	Application/Control No. 10/767,062		Applicant(s)/Patent Under Reexamination AONO ET AL.	
	Examiner Laura E. Martin		Art Unit 2853	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0073563	04-2005	Hanaki et al.	347/100
*	B	US-6,068,963	05-2000	Aoshima, Keitaro	430/270.1
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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